



N-Channel Enhancement-Mode MOSFET Transistors

PRODUCT SUMMARY				
Part Number	$V_{(BR)DSS}$ Min (V)	$r_{DS(on)}$ Max (Ω)	$V_{GS(th)}$ (V)	I_D (A)
2N6660	60	3 @ $V_{GS} = 10$ V	0.8 to 2	1.1
VQ1004J/P		3.5 @ $V_{GS} = 10$ V	0.8 to 2.5	0.46

FEATURES

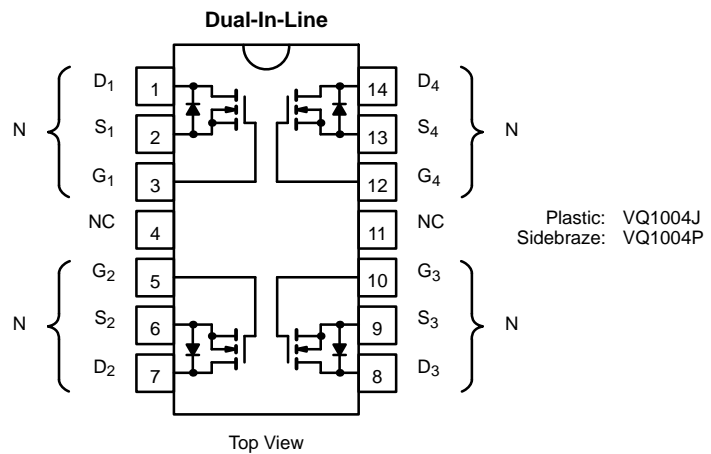
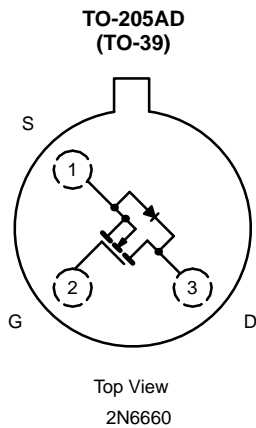
- Low On-Resistance: 1.3 Ω
- Low Threshold: 1.7 V
- Low Input Capacitance: 35 pF
- Fast Switching Speed: 8 ns
- Low Input and Output Leakage

BENEFITS

- Low Offset Voltage
- Low-Voltage Operation
- Easily Driven Without Buffer
- High-Speed Circuits
- Low Error Voltage

APPLICATIONS

- Direct Logic-Level Interface: TTL/CMOS
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories, Transistors, etc.
- Battery Operated Systems
- Solid-State Relays



ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)							
Parameter	Symbol	2N6660	Single		Total Quad	Unit	
			VQ1004J	VQ1004P	VQ1004J/P		
Drain-Source Voltage	V_{DS}	60	60	60		V	
Gate-Source Voltage	V_{GS}	± 20	± 30	± 20			
Continuous Drain Current ($T_J = 150^\circ\text{C}$)	I_D	$T_C = 25^\circ\text{C}$	1.1	0.46	± 0.46	A	
		$T_C = 100^\circ\text{C}$	0.8	0.26	0.26		
Pulsed Drain Current ^a	I_{DM}	3	2	2			
Power Dissipation	P_D	$T_C = 25^\circ\text{C}$	6.25	1.3	1.3	2	W
		$T_C = 100^\circ\text{C}$	2.5	0.52	0.52	0.8	
Maximum Junction-to-Ambient ^b	R_{thJA}	170	0.96	0.96	62.5	$^\circ\text{C/W}$	
Maximum Junction-to-Case	R_{thJC}	20					
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 150					$^\circ\text{C}$

Notes

- Pulse width limited by maximum junction temperature.
- This parameter not registered with JEDEC.

SPECIFICATIONS ^A								
Parameter	Symbol	Test Conditions	Typ ^b	Limits				Unit
				2N6660		VQ1004J/P		
				Min	Max	Min	Max	
Static								
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 10\ \mu\text{A}$	75	60		60		V
Gate-Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 1\text{ mA}$	1.7	0.8	2	0.8	2.5	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 15\text{ V}$ $T_C = 125^\circ\text{C}$			± 100		± 100	nA
					± 500		± 500	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 60\text{ V}, V_{GS} = 0\text{ V}$ $V_{DS} = 35\text{ V}, V_{GS} = 0\text{ V}$ $V_{DS} = 48\text{ V}, V_{GS} = 0\text{ V}$ $T_C = 125^\circ\text{C}$ $V_{DS} = 28\text{ V}, V_{GS} = 0\text{ V}$ $T_C = 125^\circ\text{C}$			10			μA
							1	
					500		500	
On-State Drain Current ^c	$I_{D(on)}$	$V_{DS} = 10\text{ V}, V_{GS} = 10\text{ V}$	3	1.5		1.5		A
Drain-Source On-Resistance ^c	$r_{DS(on)}$	$V_{GS} = 5\text{ V}, I_D = 0.3\text{ A}^e$ $V_{GS} = 10\text{ V}, I_D = 1\text{ A}$ $T_C = 125^\circ\text{C}^e$	2		5		5	Ω
			1.3		3		3.5	
			2.4		4.2		4.9	
Forward Transconductance ^c	g_{fs}	$V_{DS} = 10\text{ V}, I_D = 0.5\text{ A}$	350	170		170		mS
Common Source Output Conductance ^c	g_{os}	$V_{DS} = 10\text{ V}, I_D = 0.1\text{ A}$	1					
Diode Forward Voltage	V_{SD}	$I_S = 0.99\text{ A}, V_{GS} = 0\text{ V}$	0.8					V
Dynamic								
Input Capacitance	C_{iss}	$V_{DS} = 24\text{ V}, V_{GS} = 0\text{ V}$ $f = 1\text{ MHz}$	35		50		60	pF
Output Capacitance	C_{oss}		25		40		50	
Reverse Transfer Capacitance	C_{rss}		7		10		10	
Drain-Source Capacitance	C_{ds}		30		40			
Switching^d								
Turn-On Time	t_{ON}	$V_{DD} = 25\text{ V}, R_L = 23\ \Omega$ $I_D \cong 1\text{ A}, V_{GEN} = 10\text{ V}$ $R_G = 25\ \Omega$	8		10		10	ns
Turn-Off Time	t_{OFF}		8.5		10		10	

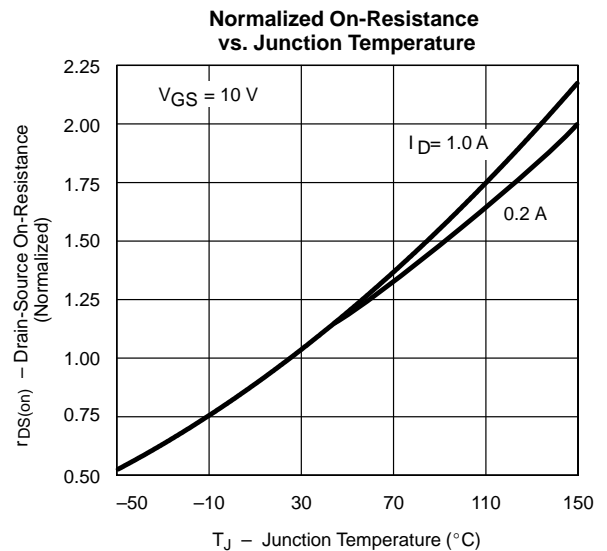
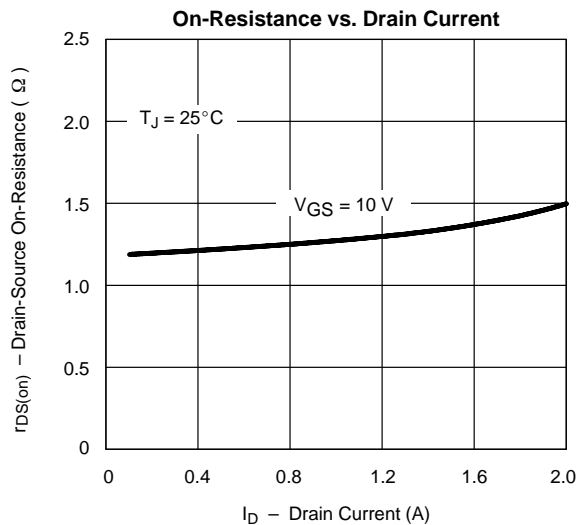
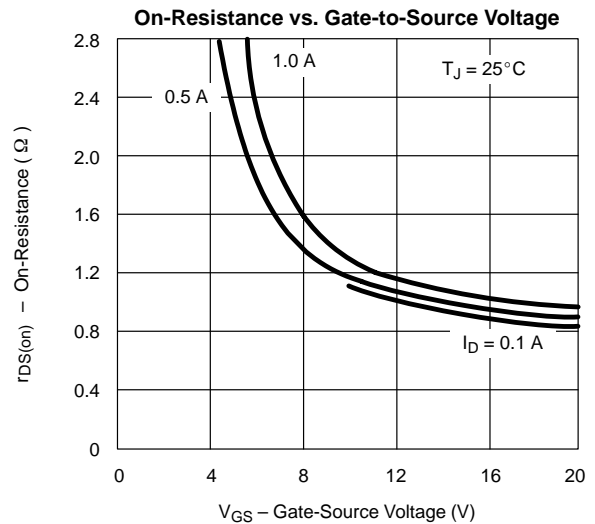
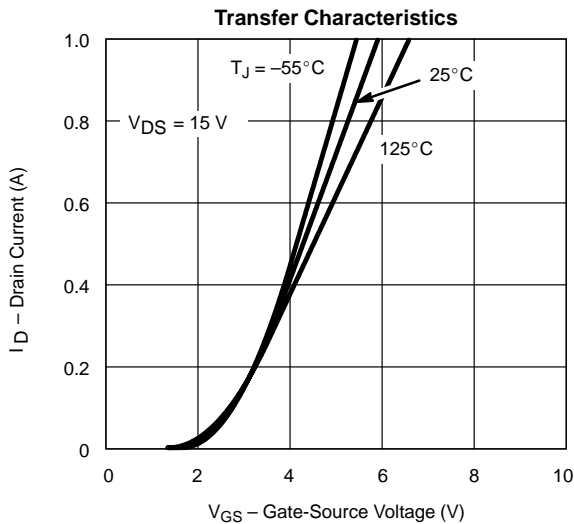
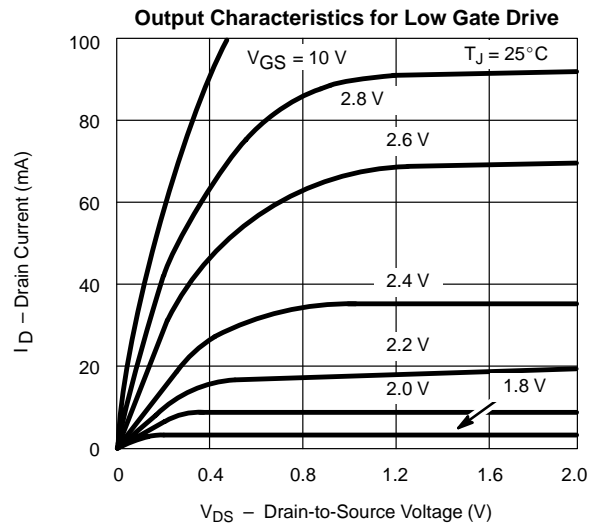
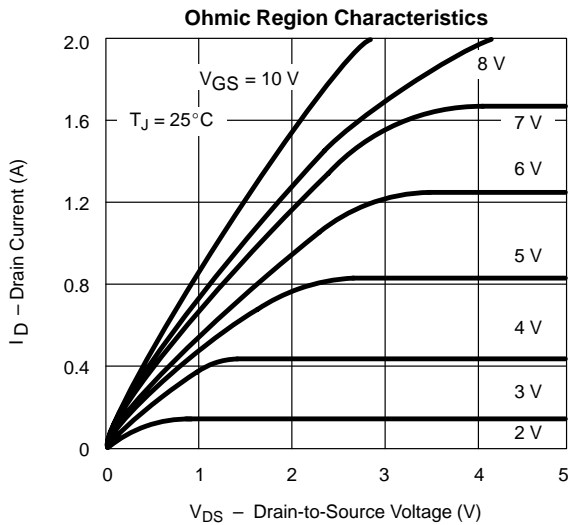
Notes

- $T_A = 25^\circ\text{C}$ unless otherwise noted.
- For DESIGN AID ONLY, not subject to production testing.
- Pulse test: $PW \leq 80\ \mu\text{s}$ duty cycle $\leq 1\%$.
- Switching time is essentially independent of operating temperature.
- This parameter not registered with JEDEC on 2N6660.

VNDQ06



TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)





TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

